
Up to 6 GHz Medium Power Silicon Bipolar Transistor

Technical Data

AT-42010

Features

- **High Output Power:**
12.0 dBm Typical $P_{1\text{dB}}$ at 2.0 GHz
20.5 dBm Typical $P_{1\text{dB}}$ at 4.0 GHz
- **High Gain at
1 dB Compression:**
14.0 dB Typical $G_{1\text{dB}}$ at 2.0 GHz
9.5 dB Typical $G_{1\text{dB}}$ at 4.0 GHz
- **Low Noise Figure:**
1.9 dB Typical NF_0 at 2.0 GHz
- **High Gain-Bandwidth
Product:** 8.0 GHz Typical f_T
- **Hermetic Gold-ceramic
Microstrip Package**

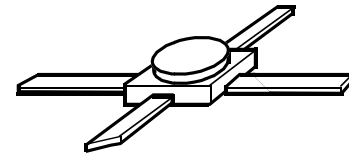
Description

Hewlett-Packard's AT-42010 is a general purpose NPN bipolar transistor that offers excellent high frequency performance. The AT-42010 is housed in a hermetic, high reliability 100 mil ceramic package. The 4 micron emitter-to-emitter pitch enables this transistor to be used in many different

functions. The 20 emitter finger interdigitated geometry yields a medium sized transistor with impedances that are easy to match for low noise and medium power applications. This device is designed for use in low noise, wideband amplifier, mixer and oscillator applications in the VHF, UHF, and microwave frequencies. An optimum noise match near $50\ \Omega$ up to 1 GHz, makes this device easy to use as a low noise amplifier.

The AT-42010 bipolar transistor is fabricated using Hewlett-Packard's 10 GHz f_T Self-Aligned-Transistor (SAT) process. The die is nitride passivated for surface protection. Excellent device uniformity, performance and reliability are produced by the use of ion-implantation, self-alignment techniques, and gold metalization in the fabrication of this device.

100 mil Package



AT-42010 Absolute Maximum Ratings^[1]

| Symbol | Parameter | Units | Absolute Maximum |
|------------------|------------------------------------|-------|------------------|
| V _{EBO} | Emitter-Base Voltage | V | 1.5 |
| V _{CBO} | Collector-Base Voltage | V | 20 |
| V _{CEO} | Collector-Emitter Voltage | V | 12 |
| I _C | Collector Current | mA | 80 |
| P _T | Power Dissipation ^[2,3] | mW | 600 |
| T _j | Junction Temperature | °C | 200 |
| T _{STG} | Storage Temperature | °C | -65 to 200 |

Thermal Resistance^[2,4]:

$$\theta_{jc} = 150^{\circ}\text{C}/\text{W}$$

Notes:

1. Permanent damage may occur if any of these limits are exceeded.
2. T_{CASE} = 25°C.
3. Derate at 6.7 mW/°C for T_C > 110°C.
4. The small spot size of this technique results in a higher, though more accurate determination of θ_{jc} than do alternate methods. See MEASUREMENTS section "Thermal Resistance" for more information.

Electrical Specifications, T_A = 25°C

| Symbol | Parameters and Test Conditions ^[1] | Units | Min. | Typ. | Max. |
|---------------------------------|---|-------|------|--------------|------|
| S _{21E} ² | Insertion Power Gain; V _{CE} = 8 V, I _C = 35 mA f = 2.0 GHz f = 4.0 GHz | dB | 10.5 | 11.5 5.5 | |
| P _{1dB} | Power Output @ 1 dB Gain Compression V _{CE} = 8 V, I _C = 35 mA f = 2.0 GHz f = 4.0 GHz | dBm | | 21.0 20.5 | |
| G _{1dB} | 1 dB Compressed Gain; V _{CE} = 8 V, I _C = 35 mA f = 2.0 GHz f = 4.0 GHz | dB | | 14.0 9.5 | |
| NF _O | Optimum Noise Figure; V _{CE} = 8 V, I _C = 10 mA f = 2.0 GHz f = 4.0 GHz | dB | | 1.9 3.0 | |
| G _A | Gain @ NF _O ; V _{CE} = 8 V, I _C = 10 mA f = 2.0 GHz f = 4.0 GHz | dB | | 13.5 10.0 | |
| f _T | Gain Bandwidth Product: V _{CE} = 8 V, I _C = 35 mA | GHz | | 8.0 | |
| h _{FE} | Forward Current Transfer Ratio; V _{CE} = 8 V, I _C = 35 mA | — | 30 | 150 | 270 |
| I _{CBO} | Collector Cutoff Current; V _{CB} = 8 V | μA | | | 0.2 |
| I _{EBO} | Emitter Cutoff Current; V _{EB} = 1 V | μA | | | 2.0 |
| C _{CB} | Collector Base Capacitance ^[1] : V _{CB} = 8 V, f = 1 MHz | pF | | 0.28 | |

Notes:

1. For this test, the emitter is grounded.

AT-42010 Typical Performance, $T_A = 25^\circ\text{C}$

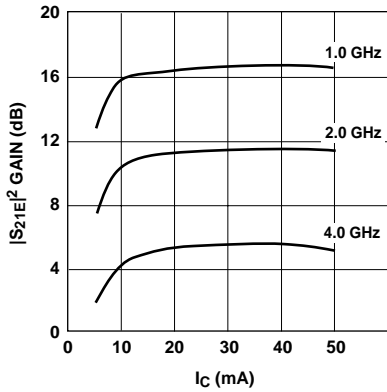


Figure 1. Insertion Power Gain vs. Collector Current and Frequency. $V_{CE} = 8\text{ V}$.

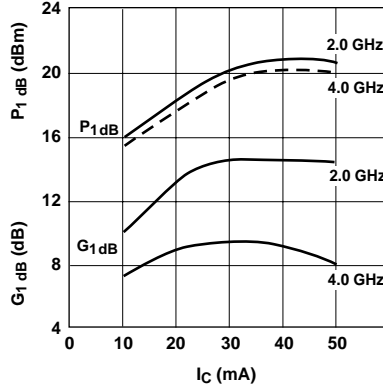


Figure 2. Output Power and 1 dB Compressed Gain vs. Collector Current and Frequency. $V_{CE} = 8\text{ V}$.

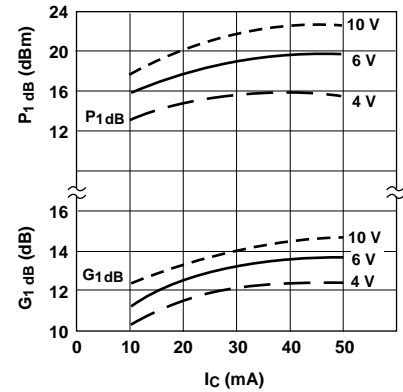


Figure 3. Output Power and 1 dB Compressed Gain vs. Collector Current and Voltage. $f = 2.0\text{ GHz}$.

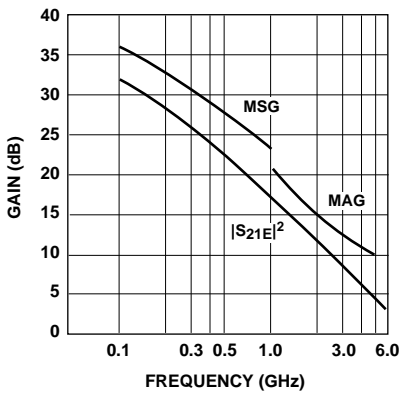


Figure 4. Insertion Power Gain, Maximum Available Gain and Maximum Stable Gain vs. Frequency. $V_{CE} = 8\text{ V}$, $I_C = 35\text{ mA}$.

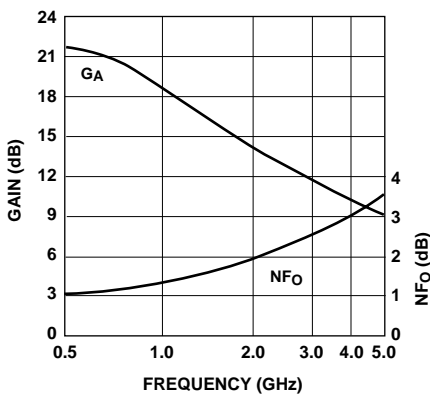


Figure 5. Noise Figure and Associated Gain vs. Frequency. $V_{CE} = 8\text{ V}$, $I_C = 10\text{ mA}$.

AT-42010 Typical Scattering Parameters, Common Emitter,

$Z_0 = 50 \Omega, T_A = 25^\circ\text{C}, V_{CE} = 8 \text{ V}, I_C = 10 \text{ mA}$

| Freq. GHz | S_{11} | | dB | S_{21} | | dB | S_{12} | | S_{22} | |
|--------------|----------|------|------|----------|------|-------|----------|------|----------|------|
| | Mag. | Ang. | | Mag. | Ang. | | Mag. | Ang. | Mag. | Ang. |
| 0.1 | .74 | -47 | 28.5 | 26.65 | 153 | -36.4 | .015 | 72 | .91 | -18 |
| 0.5 | .65 | -136 | 21.4 | 11.71 | 103 | -29.4 | .034 | 38 | .51 | -39 |
| 1.0 | .63 | -168 | 15.9 | 6.24 | 82 | -27.2 | .044 | 36 | .40 | -42 |
| 1.5 | .63 | 174 | 12.6 | 4.26 | 69 | -26.0 | .050 | 42 | .38 | -45 |
| 2.0 | .63 | 161 | 10.1 | 3.23 | 57 | -24.6 | .059 | 43 | .38 | -49 |
| 2.5 | .64 | 154 | 8.4 | 2.64 | 51 | -23.0 | .070 | 52 | .38 | -51 |
| 3.0 | .65 | 145 | 6.9 | 2.22 | 41 | -22.0 | .080 | 54 | .37 | -56 |
| 3.5 | .66 | 136 | 5.8 | 1.94 | 31 | -21.0 | .090 | 51 | .38 | -65 |
| 4.0 | .66 | 126 | 4.7 | 1.72 | 21 | -19.7 | .104 | 50 | .39 | -74 |
| 4.5 | .66 | 115 | 3.8 | 1.55 | 11 | -18.0 | .126 | 45 | .40 | -82 |
| 5.0 | .66 | 103 | 3.0 | 1.41 | 1 | -17.3 | .136 | 41 | .40 | -89 |
| 5.5 | .68 | 90 | 2.1 | 1.28 | -9 | -16.1 | .156 | 36 | .40 | -98 |
| 6.0 | .72 | 81 | 1.3 | 1.16 | -19 | -15.4 | .170 | 31 | .37 | -110 |

AT-42010 Typical Scattering Parameters,

Common Emitter, $Z_0 = 50 \Omega, T_A = 25^\circ\text{C}, V_{CE} = 8 \text{ V}, I_C = 35 \text{ mA}$

| Freq. GHz | S_{11} | | dB | S_{21} | | dB | S_{12} | | S_{22} | |
|--------------|----------|------|------|----------|------|-------|----------|------|----------|------|
| | Mag. | Ang. | | Mag. | Ang. | | Mag. | Ang. | Mag. | Ang. |
| 0.1 | .54 | -90 | 33.3 | 45.97 | 138 | -39.2 | .011 | 54 | .76 | -29 |
| 0.5 | .62 | -163 | 22.8 | 13.83 | 94 | -33.2 | .022 | 52 | .34 | -40 |
| 1.0 | .62 | 177 | 17.0 | 7.10 | 78 | -28.8 | .036 | 59 | .30 | -40 |
| 1.5 | .62 | 166 | 13.6 | 4.82 | 67 | -26.2 | .049 | 61 | .29 | -42 |
| 2.0 | .62 | 155 | 11.3 | 3.65 | 56 | -23.8 | .065 | 57 | .29 | -47 |
| 2.5 | .63 | 150 | 9.5 | 2.99 | 51 | -21.8 | .081 | 62 | .29 | -50 |
| 3.0 | .64 | 142 | 8.0 | 2.52 | 42 | -21.0 | .090 | 63 | .30 | -57 |
| 3.5 | .65 | 133 | 6.8 | 2.19 | 32 | -19.7 | .103 | 59 | .30 | -67 |
| 4.0 | .65 | 124 | 5.7 | 1.93 | 22 | -18.4 | .120 | 54 | .31 | -76 |
| 4.5 | .65 | 113 | 4.7 | 1.72 | 13 | -17.2 | .138 | 49 | .33 | -85 |
| 5.0 | .66 | 102 | 3.9 | 1.56 | 3 | -16.6 | .148 | 45 | .34 | -92 |
| 5.5 | .69 | 91 | 3.0 | 1.41 | -6 | -15.6 | .166 | 39 | .33 | -100 |
| 6.0 | .73 | 83 | 2.1 | 1.27 | -16 | -14.9 | .180 | 32 | .30 | -110 |

A model for this device is available in the DEVICE MODELS section.

AT-42010 Noise Parameters: $V_{CE} = 8 \text{ V}, I_C = 10 \text{ mA}$

| Freq. GHz | NF_0 dB | Γ_{opt} | | $R_N/50$ |
|--------------|--------------|----------------|------|----------|
| | | Mag | Ang | |
| 0.1 | 1.0 | .04 | 15 | 0.13 |
| 0.5 | 1.1 | .05 | 76 | 0.12 |
| 1.0 | 1.5 | .10 | 132 | 0.12 |
| 2.0 | 1.9 | .23 | -177 | 0.11 |
| 4.0 | 3.0 | .45 | -125 | 0.26 |

100 mil Package Dimensions

